

Notice of References Cited

Application/Control No.

10/507,291

Applicant(s)/Patent Under
Reexamination
BEAUDOU ET AL.

Examiner

DEVIN ALMEIDA

Art Unit

2432

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U.S. PATENT DOCUMENTS

*	Document Number		Date	Name	Classification
	Country Code-Number-Kind Code		MM-YYYY		
*	A	US-6,907,123	06-2005	Schier, John E.	380/28
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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